











LMV931-N LMV932-N, LMV934-N

SNOS993P - NOVEMBER 2001 - REVISED APRIL 2017

# LMV93x-N Single, Dual, Quad 1.8-V, RRIO Operational Amplifiers

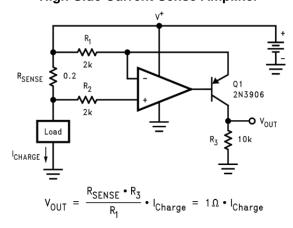
#### **Features**

- Typical 1.8-V Supply Values; Unless Otherwise
- Specified at 1.8 V, 2.7 V and 5 V
- **Output Swing** 
  - With 600-Ω Load 80 mV from Rail
  - With 2-kΩ Load 30 mV from Rail
- V<sub>CM</sub> 200 mV Beyond Rails
- Supply Current (per Channel) 100 μA
- Gain Bandwidth Product 1.4 MHz
- Maximum V<sub>OS</sub> 4 mV
- Ultra Tiny Packages
- Temperature Range -40°C to +125°C
- Create a Custom Design Using the LMV93x-N With the WEBENCH® Power Designer

# **Applications**

- **Phones**
- **Tablets**
- Wearables
- Health Monitoring
- Portable and Battery-Powered Electronic Equipment
- **Battery Monitoring**

#### **High-Side Current Sense Amplifier**



# 3 Description

The LMV93x-N family (LMV931-N single, LMV932-N dual and LMV934-N quad) are low-voltage, lowpower operational amplifiers. The LMV93x-N family operates from 1.8-V to 5.5-V supply voltages and have rail-to-rail input and output. The input commonmode voltage extends 200 mV beyond the supplies which enables user enhanced functionality beyond the supply voltage range. The output can swing railto-rail unloaded and within 105 mV from the rail with  $600-\Omega$  load at 1.8-V supply. The LMV93x-N devices are optimized to work at 1.8 V, which make them ideal for portable two-cell, battery-powered systems and single-cell Li-lon systems.

LMV93x-N devices exhibit an excellent speed-power ratio, achieving 1.4-MHz gain bandwidth product at 1.8-V supply voltage with very low supply current. The LMV93x-N devices can drive a 600-Ω load and up to 1000-pF capacitive load with minimal ringing. These devices also have a high DC gain of 101 dB, making them suitable for low-frequency applications.

The single LMV93x-N is offered in space-saving 5-pin SC70 and SOT-23 packages. The dual LMV932-N are in 8-pin VSSOP and SOIC packages and the quad LMV934-N are in 14-pin TSSOP and SOIC packages. These small packages are ideal solutions for area constrained PC boards and portable electronics such as mobile phones and tablets.

# Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)					
LMV931-N	SOT-23 (5)	2.90 mm × 1.60 mm					
LIVIV931-IN	SC-70 (5)	2.00 mm x 1.25 mm					
LMV932-N	VSSOP (8)	3.00 mm × 3.00 mm					
LIVIV932-IN	SOIC (8)	4.90 mm × 3.91 mm					
LMV934-N	TSSOP (8)	5.00 mm × 4.40 mm					
LIVIV934-IN	SOIC (14)	8.60 mm × 3.90 mm					

(1) For all available packages, see the orderable addendum at the end of the datasheet.



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# 4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

CI	nanges from Revision O (December 2014) to Revision P	Page
•	Deleted information specific to automotive grade - created separate automotive data sheet SNOSD49	1
•	Added links for WEBENCH	1
•	Moved storage temperature to Abs Max table and changed Handling Ratings tables to ESD Ratings tables per r	
•	Changed values in the <i>Thermal Information</i> table to align with JEDEC standards	4
•	Changed Slew Rate vs Supply Voltage title to reflect LMV931 and LMV934 only	14
•	Added Slew Rate vs Supply graph for LMV932 only	14
•	Added Receiving Notification of Documentation Updates and Community Resources subsections	25
	Added Pin Configuration and Functions section, Handling Rating table, Feature Description section, Device Functional Modes, Application and Implementation, Power Supply Recommendations, Layout, Device and Documentation Support, and Mechanical, Packaging, and Orderable Information sections	1
CI	nanges from Revision M (November 2013) to Revision N	Page
•	Complete rewrite for GDS standard.	1
•	Added LMV934-N-Q1. The other Q grades were added in previous revision	1
_		5
C	nanges from Revision L (March 2013) to Revision M	Page

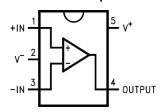
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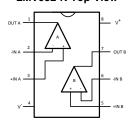


# 5 Pin Configuration and Functions

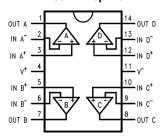
DBV and DCK Package 5-Pin SC-70 and SOT-23 LMV931-N Top View



#### DGK and D Package 8-Pin VSSOP and SOIC LMV932-N Top View



#### DGK and D Package 14-Pin TSSOP and SOIC LMV934-N Top View



#### Pin Functions: LMV931

	PIN		DESCRIPTION
NAME	LMV931 DBV, DCK	I/O	DESCRIPTION
+IN	1	I	Noninverting Input
-IN	3	I	Inverting Input
OUT	4	0	Output
V-	2	Р	Negative Supply
V+	5	Р	Positive Supply

# Pin Functions: LMV932 and LMV934

	THE UNIONS. EMPOST AND EMPOST								
	PIN		1/0	DESCRIPTION					
NAME	LMV932 D, DGK	LMV934 D, PW	1/0	DESCRIPTION					
+IN A	3	3	I	Noninverting input, channel A					
+IN B	5	5	I	Noninverting input, channel B					
+IN C	_	10	I	Noninverting input, channel C					
+IN D	_	12	I	Noninverting input, channel D					
–IN A	2	2	I	Inverting input, channel A					
–IN B	6	6	I	Inverting input, channel B					
-IN C	_	9	I	Inverting input, channel C					
–IN D	_	13	I	Inverting input, channel D					
OUT A	1	1	0	Output, channel A					
OUT B	7	7	0	Output, channel B					
OUT C	_	8	0	Output, channel C					
OUT D	_	14	0	Output, channel D					
V+	8	4	Р	Positive (highest) power supply					
V–	4	11	Р	Negative (lowest) power supply					

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# 6 Specifications

#### 6.1 Absolute Maximum Ratings

See (1)(2).

	MIN	MAX	UNIT
Supply voltage ( V <sup>+</sup> – V <sup>-</sup> )	-0.3	6	V
Differential input voltage	V <sup>-</sup>	V <sup>+</sup>	V
Voltage at input/output pins	(V <sup>-</sup> ) - 0.3	$(V^+) + 0.3$	V
Junction temperature <sup>(3)</sup>	-40	150	°C
Storage temperature, T <sub>stg</sub>	-65	150	°C

- (1) Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Recommended Operating Conditions indicate conditions for which the device is intended to be functional, but specific performance is not specified. For specifications and the test conditions, see the Electrical Characteristics.
- (2) If Military/Aerospace specified devices are required, contact the TI Sales Office/Distributors for availability and specifications.
- (3) The maximum power dissipation is a function of  $T_{J(max)}$ ,  $R_{\theta JA}$ , and  $T_A$ . The maximum allowable power dissipation at any ambient temperature is  $P_D = (T_{J(max)} T_A)/R_{\theta JA}$ . All numbers apply for packages soldered directly into a PC board.

### 6.2 ESD Ratings (Commercial)

			VALUE	UNIT
		Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 (1)	±2000	
V <sub>(ESD)</sub>	Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 (2)	±750	V
		Machine model (MM) <sup>(3)</sup>	±200	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.
- (3) Machine model, 200  $\Omega$  in series with 100 pF.

# 6.3 Recommended Operating Ratings

See<sup>(1)</sup>.

	MIN	MAX	UNIT
Supply voltage range ( V <sup>+</sup> – V <sup>-</sup> )	1.8	5.5	V
Ambient temperature	-40	125	°C

<sup>(1)</sup> Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Recommended Operating Conditions indicate conditions for which the device is intended to be functional, but specific performance is not specified. For specifications and the test conditions, see the Electrical Characteristics.

#### 6.4 Thermal Information

	THERMAL METRIC <sup>(1)</sup>		931-N	LMV932-N		LMV934-N		
			DCK (SC70)	D (SOIC)	DGK (VSSOP)	D (SOIC)	PW (TSSOP)	UNIT
		5 PINS	5 PINS	8 PINS	8 PINS	14 PINS	14 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	197.2	285.9	125.9	184.5	94.4	124.8	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	156.7	115.9	70.2	74.3	52.5	51.4	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	55.6	63.7	66.5	105.1	48.9	67.2	°C/W
ΨЈТ	Junction-to-top characterization parameter	41.4	4.5	19.8	13.1	14.3	6.6	°C/W
ΨЈВ	Junction-to-board characterization parameter	55	62.9	65.9	103.6	48.6	66.6	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	_	_	_	_	_	_	°C/W

 For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.



## 6.5 DC Electrical Characteristics 1.8 V

Unless otherwise specified, all limits specified for  $T_J$  = 25°C.  $V^+$  = 1.8 V,  $V^-$  = 0 V,  $V_{CM}$  =  $V^+/2$ ,  $V_O$  =  $V^+/2$  and  $R_L$  > 1 M $\Omega$ .

	PARAMETER	TEST CONDIT	IONS	MIN	TYP (1)	MAX	UNIT
		LMV931 (Single)	25°C		1	4	.,
. ,			Full Range			6	mV
Vos	Input Offset Voltage	LMV932 (Dual),	25°C		1	5.5	.,
		LMV934 (Quad)	Full Range			7.5	mV
TCV <sub>OS</sub>	Input Offset Voltage Average Drift		Full Range		5.5		μV/°C
I <sub>B</sub>	Input Bias Current		25°C		15	35	<b>π</b> Λ
			Full Range			50	nA
Ios	Input Offset Current		25°C		13	25	^
			Full Range			nA 40	
I <sub>S</sub>	Supply Current (per channel)		25°C		103	185	
			Full Range			205	μА
CMRR	Common-Mode Rejection Ratio	LMV931, $0 \le V_{CM} \le 0.6 \text{ V}$	25°C	60	78		
		$1.4 \text{ V} \le \text{V}_{\text{CM}} \le 1.8 \text{ V}^{(2)}$	Full Range	55			dB
		LMV932 and LMV934	25°C	55	76		
		$0 \le V_{CM} \le 0.6 \text{ V}$ 1.4 V $\le V_{CM} \le 1.8 \text{ V}^{(2)}$	Full Range	50			dB
		$-0.2 \text{ V} \le \text{V}_{\text{CM}} \le 0 \text{ V}$ 1.8 V $\le \text{V}_{\text{CM}} \le 2.0 \text{ V}$	25°C	50	72		dB
PSRR	Power Supply Rejection Ratio	$1.8 \text{ V} \le \text{V}^+ \le 5 \text{ V}$	25°C	75	100		dB
			Full Range	70			
CMVR	Input Common-Mode Voltage	For CMRR Range ≥ 50dB	25°C	V <sup>-</sup> - 0.2	-0.2	$V^+ + 0.2$	
	Range		-40°C to 85°C	V <sup>-</sup>	to	V <sup>+</sup>	V
			125°C	V <sup>-</sup> + 0.2	2.1	V <sup>+</sup> - 0.2	
		$R_L = 600 \Omega \text{ to } 0.9 \text{ V},$	25°C	77	101		
	Large Signal Voltage Gain	$V_O = 0.2 \text{ V to } 1.6 \text{ V},$ $V_{CM} = 0.5 \text{ V}$	Full Range	73			dB
	LMV931-N (Single)	$R_L = 2 k\Omega \text{ to } 0.9 \text{ V},$	25°C	80	105		-10
Δ		$V_O = 0.2 \text{ V to } 1.6 \text{ V},$ $V_{CM} = 0.5 \text{ V}$	Full Range	75			dB
$A_V$		$R_L = 600 \Omega \text{ to } 0.9 \text{ V},$	25°C	75	90		
	Large Signal Voltage Gain	$V_O = 0.2 \text{ V to } 1.6 \text{ V},$ $V_{CM} = 0.5 \text{ V}$	Full Range	72			dB
	LMV932-N (Dual) LMV934-N (Quad)	$R_L = 2 k\Omega$ to 0.9 V,	25°C	78	100		
	Linvoo i iv (Quad)	$V_O = 0.2 \text{ V to } 1.6 \text{ V},$ $V_{CM} = 0.5 \text{ V}$	Full Range	75			dB
		$R_L = 600 \Omega \text{ to } 0.9 \text{ V}$	25°C	1.65	1.72		
		$V_{IN} = \pm 100 \text{ mV}$			0.077	0.105	V
	Outract Outract		Full Range	1.63		0.120	
V <sub>O</sub>	Output Swing	$R_L = 2 k\Omega$ to 0.9 V	25°C	1.75	1.77		
		$V_{IN} = \pm 100 \text{ mV}$			0.024	0.035	V
			Full Range	1.74		0.04	

<sup>(1)</sup> Typical values represent the most likely parametric norm as determined at the time of characterization. Actual typical values may vary over time and will also depend on the application and configuration.

<sup>(2)</sup> For specified temperature ranges, see the CMVR parameter in *DC Electrical Characteristics 1.8 V* for the input common-mode voltage specifications.



### DC Electrical Characteristics 1.8 V (continued)

Unless otherwise specified, all limits specified for  $T_J$  = 25°C.  $V^+$  = 1.8 V,  $V^-$  = 0 V,  $V_{CM}$  =  $V^+/2$ ,  $V_O$  =  $V^+/2$  and  $R_L$  > 1 M $\Omega$ .

	PARAMETER	TEST CONDITIONS		MIN	TYP (1)	MAX	UNIT
I <sub>O</sub> Output Short Circuit Cu	0 0	Sourcing, $V_O = 0 V$ $V_{IN} = 100 \text{ mV}$	25°C	4	8		mA
			Full Range	3.3			
	Output Short Circuit Current	V = =100 mV	25°C	7	9		A
			Full Range	5			mA

<sup>(3)</sup> Applies to both single-supply and split-supply operation. Continuous short circuit operation at elevated ambient temperature can result in exceeding the maximum allowed junction temperature of 150°C. Output currents in excess of 45 mA over long term may adversely affect reliability.

## 6.6 AC Electrical Characteristics 1.8 V

Unless otherwise specified, all limits specified for  $T_J$  = 25°C.  $V^+$  = 1.8 V,  $V^-$  = 0 V,  $V_{CM}$  =  $V^+/2$ ,  $V_O$  =  $V^+/2$  and  $R_L$  > 1 M $\Omega$ .

	PARAMETER	TEST CONDITIONS	MIN TYP (1) MA	X UNIT
SR	Slew Rate	See <sup>(2)</sup> .	0.35	V/μs
GBW	Gain-Bandwidth Product		1.4	MHz
$\Phi_{m}$	Phase Margin		67	deg
G <sub>m</sub>	Gain Margin		7	dB
e <sub>n</sub>	Input-Referred Voltage Noise	f = 10 kHz, V <sub>CM</sub> = 0.5 V	60	nV/√ <del>Hz</del>
i <sub>n</sub>	Input-Referred Current Noise	f = 10 kHz	0.08	pA/√ <del>Hz</del>
THD	Total Harmonic Distortion	$f = 1 \text{ kHz}, A_V = +1 \\ R_L = 600 \ \Omega, V_{IN} = 1 \ V_{PP}$	0.023%	
	Amplifier-to-Amplifier Isolation	See <sup>(3)</sup>	123	dB

<sup>(1)</sup> Typical values represent the most likely parametric norm as determined at the time of characterization. Actual typical values may vary over time and will also depend on the application and configuration.

#### 6.7 DC Electrical Characteristics 2.7 V

Unless otherwise specified, all limits specified for  $T_J = 25$  °C.  $V^+ = 2.7$  V,  $V^- = 0$  V,  $V_{CM} = V^+/2$ ,  $V_O = V^+/2$  and  $R_L > 1$  M $\Omega$ .

PARAMETER		TEST COM	IDITIONS	MIN	TYP (1)	MAX	UNIT
		LMV931 (Single)	25°C		1	4	m)/
	land Offer at Valtage		Full Range			6	mV
V <sub>OS</sub> Inpu	Input Offset Voltage	LMV932 (Dual)	25°C		1	5.5	
		LMV934 (Quad)	Full Range			7.5	mV
TCV <sub>OS</sub>	Input Offset Voltage Average Drift		Full Range		5.5		μV/°C
I <sub>B</sub>	Input Bias Current		25°C		15	35	<b>π</b> Λ
			Full Range			50	nA
los	Input Offset Current		25°C		8	25	^
			Full Range			40	nA
Is	Supply Current (per channel)		25°C		105	190	^
			Full Range			210	μА

<sup>(2)</sup> Connected as voltage follower with input step from V<sup>-</sup> to V<sup>+</sup>. Number specified is the slower of the positive and negative slew rates.

<sup>(3)</sup> Input referred,  $R_L = 100 \text{ k}\Omega$  connected to V<sup>+</sup>/2. Each amplifier excited in turn with 1 kHz to produce  $V_O = 3 \text{ V}_{PP}$  (For supply voltages < 3 V,  $V_O = V^+$ ).

<sup>(1)</sup> Typical values represent the most likely parametric norm as determined at the time of characterization. Actual typical values may vary over time and will also depend on the application and configuration.



# DC Electrical Characteristics 2.7 V (continued)

Unless otherwise specified, all limits specified for  $T_J$  = 25°C.  $V^+$  = 2.7 V,  $V^-$  = 0 V,  $V_{CM}$  =  $V^+/2$ ,  $V_O$  =  $V^+/2$  and  $R_L$  > 1 M $\Omega$ .

PARAMI	ETER	TEST CONDITI	ONS	MIN	TYP (1)	MAX	UNIT	
		LMV931, $0 \le V_{CM} \le 1.5 \text{ V}$	25°C	60	81		-ID	
		$2.3 \text{ V} \le \text{V}_{\text{CM}} \le 2.7 \text{ V}^{(2)}$	Full Range	55			dB	
OMPR	Occasion Made Balastina Batis	LMV932 and LMV934	25°C	55	80			
CMRR	Common-Mode Rejection Ratio	$0 \le V_{CM} \le 1.5 \text{ V}$ 2.3 V $\le V_{CM} \le 2.7 \text{ V}^{(2)}$	Full Range	50			dB	
		$-0.2 \text{ V} \le \text{V}_{\text{CM}} \le 0 \text{ V}$ 2.7 \text{ V} \le \text{V}_{\text{CM}} \le 2.9 \text{ V}	25°C	50	74		dB	
PSRR	Power Supply Rejection Ratio	1.8 V ≤ V <sup>+</sup> ≤ 5 V	25°C	75	100		dB	
PSKK	Power Supply Rejection Ratio	$V_{CM} = 0.5 \text{ V}$	Full Range	70			ub	
		For CMRR Range ≥ 50 dB	25°C	V <sup>-</sup> - 0.2	-	$V^+ + 0.2$		
$V_{\text{CM}}$	Input Common-Mode Voltage Range		-40°C to 85°C	V <sup>-</sup>	to = 3.0 =	V+ \	V	
İ	rango		125°C	V <sup>-</sup> + 0.2	0.0 -	V <sup>+</sup> - 0.2		
		$R_L = 600 \Omega \text{ to } 1.35 \text{ V},$	25°C	87	104		dB	
	Large Signal Voltage Gain	$V_0 = 0.2 \text{ V to } 2.5 \text{ V}$	Full Range	86			uБ	
	LMV931-N (Single)	$R_L = 2 k\Omega$ to 1.35 V,	25°C	92	110		dB	
Δ		$V_0 = 0.2 \text{ V to } 2.5 \text{ V}$	Full Range	91			uБ	
$A_V$		$R_L = 600 \Omega \text{ to } 1.35 \text{ V},$	25°C	78	90		dB	
	Large Signal Voltage Gain LMV932-N (Dual)	$V_0 = 0.2 \text{ V to } 2.5 \text{ V}$	Full Range	75				
	LMV932-N (Duai) LMV934-N (Quad)	$R_L = 2 k\Omega$ to 1.35 V,	25°C	81	100		٩D	
	, ,	$V_0 = 0.2 \text{ V to } 2.5 \text{ V}$	Full Range	78			dB	
		$R_L = 600 \Omega \text{ to } 1.35 \text{ V}$	25°C	2.55	2.62			
		$V_{IN} = \pm 100 \text{ mV}$			0.083	0.110	V	
V	Output Swing		Full Range	2.53		0.130		
Vo	Output Swing	$R_L = 2 k\Omega$ to 1.35 V	25°C	2.65	2.675			
		$V_{IN} = \pm 100 \text{ mV}$			0.025	0.04	V	
			Full Range	2.64		0.045		
		Sourcing, V <sub>O</sub> = 0 V	25°C	20	30		A	
	(0)	$V_{IN} = +100 \text{ mV}$	Full Range	15			mA	
l <sub>O</sub>	Output Short Circuit Current (3)	Sinking,	25°C	18	25			
		$V_O = 2.7 \text{ V}$ $V_{IN} = -100 \text{ mV}$	Full Range	12			mA	

<sup>(2)</sup> For specified temperature ranges, see the CMVR parameter in DC Electrical Characteristics 1.8 V for the input common-mode voltage specifications.

#### 6.8 AC Electrical Characteristics 2.7 V

Unless otherwise specified, all limits specified for  $T_J = 25^{\circ}C$ .  $V^+ = 2.7$  V,  $V^- = 0$  V,  $V_{CM} = 1.0$  V,  $V_O = 1.35$  V and  $R_L > 1$  M $\Omega$ .

PARAMI	ETER	TEST CONDITIONS	MIN	TYP (1)	MAX	UNIT
SR	Slew Rate	See <sup>(2)</sup>		0.4		V/µs
GBW	Gain-Bandwidth Product			1.4		MHz
$\Phi_{m}$	Phase Margin			70		deg
G <sub>m</sub>	Gain Margin			7.5		dB
e <sub>n</sub>	Input-Referred Voltage Noise	$f = 10 \text{ kHz}, V_{CM} = 0.5 \text{ V}$		57		nV√ <del>Hz</del>
i <sub>n</sub>	Input-Referred Current Noise	f = 10 kHz		0.08		pA/√Hz

<sup>(1)</sup> Typical values represent the most likely parametric norm as determined at the time of characterization. Actual typical values may vary over time and will also depend on the application and configuration.

<sup>(3)</sup> Applies to both single-supply and split-supply operation. Continuous short circuit operation at elevated ambient temperature can result in exceeding the maximum allowed junction temperature of 150°C. Output currents in excess of 45 mA over long term may adversely affect reliability.

<sup>(2)</sup> Connected as voltage follower with input step from V<sup>-</sup> to V<sup>+</sup>. Number specified is the slower of the positive and negative slew rates.



# AC Electrical Characteristics 2.7 V (continued)

Unless otherwise specified, all limits specified for  $T_J = 25^{\circ}C$ .  $V^+ = 2.7$  V,  $V^- = 0$  V,  $V_{CM} = 1.0$  V,  $V_O = 1.35$  V and  $R_L > 1$  M $\Omega$ .

PARAM	METER	TEST CONDITIONS	MIN	TYP (1)	MAX	UNIT
THD	Total Harmonic Distortion	$ f = 1 \text{ kHz}, A_V = +1 \\ R_L = 600 \ \Omega, V_{IN} = 1 \ V_{PP} $		0.022%		
	Amp-to-Amp Isolation	See <sup>(3)</sup>		123		dB

<sup>(3)</sup> Input referred,  $R_L = 100 \text{ k}\Omega$  connected to V<sup>+</sup>/2. Each amplifier excited in turn with 1 kHz to produce  $V_O = 3 \text{ V}_{PP}$  (For supply voltages < 3 V,  $V_O = V^+$ ).



#### 6.9 Electrical Characteristics 5 V DC

Unless otherwise specified, all limits specified for  $T_J = 25^{\circ}C$ .  $V^+ = 5$  V,  $V^- = 0$  V,  $V_{CM} = V^+/2$ ,  $V_O = V^+/2$  and  $R_L > 1$  M $\Omega$ .

PARAME	TER	TEST CONDIT	MIN	TYP (1)	MAX	UNIT		
		LMV931 (Single)	25°C		1	4		
\ /	Innut Offeet Valley		Full Range			6	mV	
Vos	Input Offset Voltage	LMV932 (Dual)	25°C		1	5.5		
		LMV934 (Quad)	Full Range			7.5	mV	
TCV <sub>OS</sub>	Input Offset Voltage Average Drift				5.5		μV/°C	
I <sub>B</sub>	Input Bias Current		25°C		14	35	nA	
			Full Range			50	IIA	
Ios	Input Offset Current		25°C		9	25	n ^	
			Full Range			40	nA	
I <sub>S</sub>	Supply Current (per channel)		25°C		116	210	^	
			Full Range			230	μΑ	
		$0 \le V_{CM} \le 3.8 \text{ V}$	25°C	60	86		dB	
CMRR	Common-Mode Rejection Ratio	$4.6 \text{ V} \le \text{V}_{\text{CM}} \le 5 \text{ V}^{(2)}$	Full Range	55			αБ	
OWNER	Common wode rejection realio	$-0.2 \text{ V} \le \text{V}_{\text{CM}} \le 0 \text{ V}$ 5 \text{V} \sum \text{V}_{\text{CM}} \le 5.2 \text{V}	25°C	50	78		dB	
DCDD	Dawer Cumply Dejection Datio	1.8 V ≤ V <sup>+</sup> ≤ 5 V	25°C	75	100		٩D	
PSRR	Power Supply Rejection Ratio	$V_{CM} = 0.5 \text{ V}$	Full Range	70			dB	
		For CMRR Range ≥ 50 dB	25°C	V <sup>-</sup> - 0.2	-0.2	$V^{+} + 0.2$		
CMVR	Input Common-Mode Voltage Range		-40°C to 85°C	V <sup>-</sup>	to	V <sup>+</sup>	V	
	rango		125°C	V <sup>-</sup> + 0.3	5.3	V <sup>+</sup> - 0.3		
	Large Signal Voltage Gain LMV931-N (Single)	$R_L = 600 \Omega \text{ to } 2.5 \text{ V},$	25°C	88	102		٩D	
		$V_0 = 0.2 \text{ V to } 4.8 \text{ V}$	Full Range	87			dB	
		$R_L = 2 k\Omega$ to 2.5 V,	25°C	94	113		dB	
۸		$V_0 = 0.2 \text{ V to } 4.8 \text{ V}$	Full Range	93			dB	
$A_V$		$R_L = 600 \Omega \text{ to } 2.5 \text{ V},$	25°C	81	90		٩D	
	Large Signal Voltage Gain	$V_0 = 0.2 \text{ V to } 4.8 \text{ V}$	Full Range	78			dB	
	LMV932-N (Dual) LMV934-N (Quad)	$R_L = 2 k\Omega$ to 2.5 V,	25°C	85	100		٩D	
	(31333)	$V_0 = 0.2 \text{ V to } 4.8 \text{ V}$	Full Range	82			dB	
		$R_L = 600 \Omega$ to 2.5 V	25°C	4.855	4.890			
		$V_{IN} = \pm 100 \text{ mV}$			0.120	0.160	V	
V	Outrast Curina		Full Range	4.835		0.180		
Vo	Output Swing	$R_L = 2 k\Omega$ to 2.5 V	25°C	4.945	4.967			
		$V_{IN} = \pm 100 \text{ mV}$			0.037	0.065	V	
			Full Range	4.935		0.075		
		LMV931, Sourcing, V <sub>O</sub> = 0	25°C	80	100			
l <sub>o</sub>	Output Short Circuit Current <sup>(3)</sup>	V V <sub>IN</sub> = +100 mV	Full Range	68			mA	
J	S S	Sinking, V <sub>O</sub> = 5 V	25°C	58	65		m ^	
		$V_{IN} = -100 \text{ mV}$	Full Range	45			mA	

<sup>(1)</sup> Typical values represent the most likely parametric norm as determined at the time of characterization. Actual typical values may vary over time and will also depend on the application and configuration.

<sup>(2)</sup> For specified temperature ranges, see the CMVR parameter in *DC Electrical Characteristics 1.8* V for the input common-mode voltage specifications.

<sup>(3)</sup> Applies to both single-supply and split-supply operation. Continuous short circuit operation at elevated ambient temperature can result in exceeding the maximum allowed junction temperature of 150°C. Output currents in excess of 45 mA over long term may adversely affect reliability.



#### 6.10 AC Electrical Characteristics 5 V

Unless otherwise specified, all limits specified for  $T_J$  = 25°C.  $V^+$  = 5 V,  $V^-$  = 0 V,  $V_{CM}$  =  $V^+/2$ ,  $V_O$  = 2.5 V and R  $_L$  > 1 M $\Omega$ .

	PARAMETER	TEST CONDITIONS	MIN TYP (1)	MAX	UNIT
SR	Slew Rate	See . <sup>(2)</sup>	0.42		V/µs
GBW	Gain-Bandwidth Product		1.5		MHz
$\Phi_{m}$	Phase Margin		71		deg
G <sub>m</sub>	Gain Margin		8		dB
e <sub>n</sub>	Input-Referred Voltage Noise	f = 10 kHz, V <sub>CM</sub> = 1 V	50		nV/√ <del>Hz</del>
i <sub>n</sub>	Input-Referred Current Noise	f = 10 kHz	0.08		pA/√ <del>Hz</del>
THD	Total Harmonic Distortion	$f = 1 \text{ kHz}, A_V = 1$ $R_L = 600 \Omega, V_O = 1 V_{PP}$	0.022%		
	Amplifier-to-Amplifier Isolation	See <sup>(3)</sup>	123		dB

<sup>(1)</sup> Typical values represent the most likely parametric norm as determined at the time of characterization. Actual typical values may vary over time and will also depend on the application and configuration. Connected as voltage follower with input step from  $V^-$  to  $V^+$ . Number specified is the slower of the positive and negative slew rates. Input referred,  $R_L = 100 \text{ k}\Omega$  connected to  $V^+/2$ . Each amplifier excited in turn with 1 kHz to produce  $V_O = 3 V_{PP}$  (For supply voltages < 3

 $V, V_{O} = V^{+}$ ).



# 6.11 Typical Characteristics

Unless otherwise specified,  $V_S = 5 \text{ V}$ , single-supply,  $T_A = 25 ^{\circ}\text{C}$ .

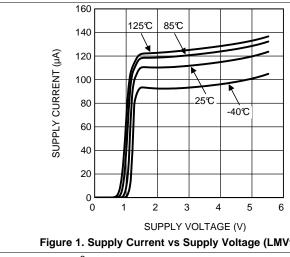


Figure 1. Supply Current vs Supply Voltage (LMV931-N)

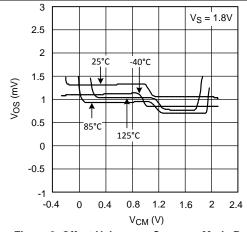


Figure 2. Offset Voltage vs Common-Mode Range

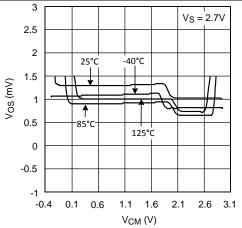


Figure 3. Offset Voltage vs Common-Mode Range

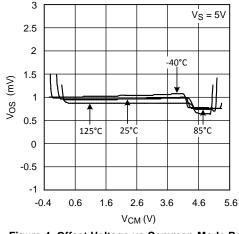
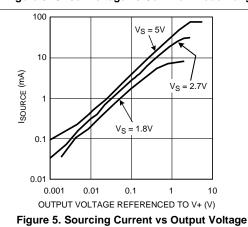
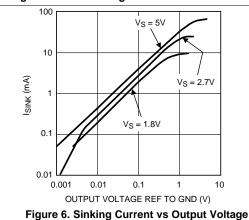


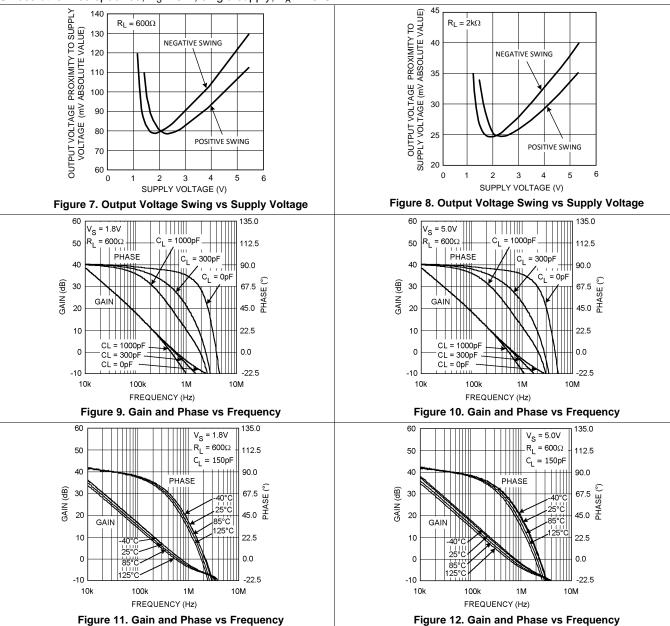
Figure 4. Offset Voltage vs Common-Mode Range





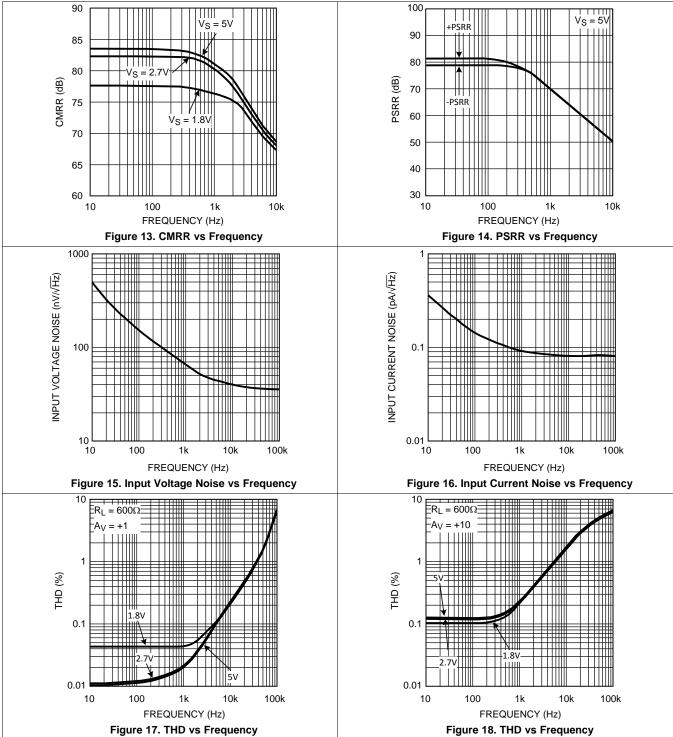


Unless otherwise specified,  $V_S = 5 \text{ V}$ , single-supply,  $T_A = 25^{\circ}\text{C}$ .



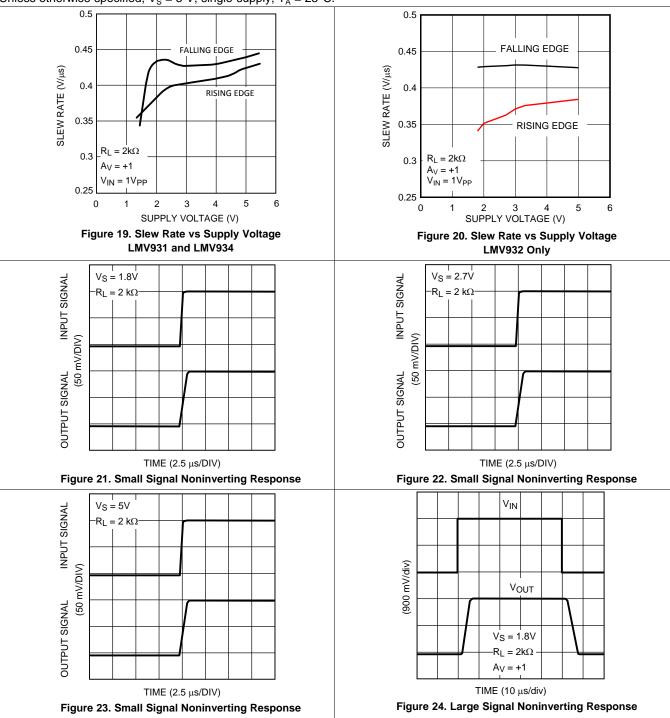


Unless otherwise specified,  $V_S = 5 \text{ V}$ , single-supply,  $T_A = 25 ^{\circ}\text{C}$ .





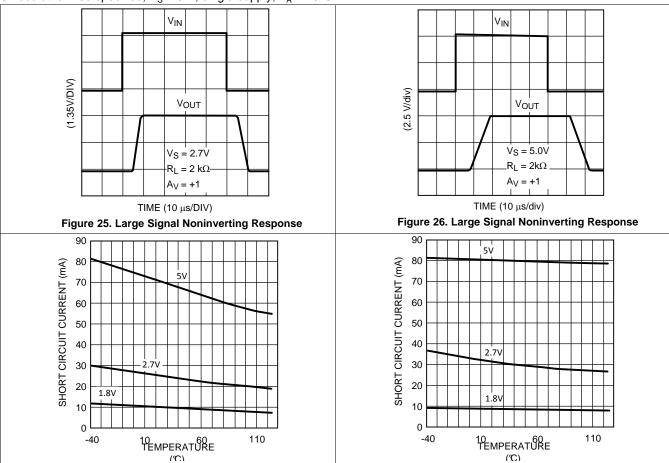
Unless otherwise specified,  $V_S = 5 \text{ V}$ , single-supply,  $T_A = 25^{\circ}\text{C}$ .





Unless otherwise specified,  $V_S = 5 \text{ V}$ , single-supply,  $T_A = 25^{\circ}\text{C}$ .

Figure 27. Short Circuit Current vs Temperature (Sinking)



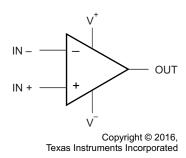


# 7 Detailed Description

#### 7.1 Overview

The LMV93x-N are low-voltage, low-power operational amplifiers (op-amp) operating from 1.8-V to 5.5-V supply voltages and have rail-to-rail input and output. LMV93x-N input common-mode voltage extends 200 mV beyond the supplies which enables user enhanced functionality beyond the supply voltage range.

### 7.2 Functional Block Diagram



(Each Amplifier)

## 7.3 Feature Description

The differential inputs of the amplifier consist of a noninverting input (+IN) and an inverting input (-IN). The amplifier amplifies only the difference in voltage between the two inputs, which is called the differential input voltage. The output voltage of the op-amp  $V_{OUT}$  is given by Equation 1:

$$V_{OUT} = A_{OL} (IN^+ - IN^-)$$

where

A<sub>OI</sub> is the open-loop gain of the amplifier, typically around 100 dB (100,000x, or 10 μV per volt).

#### 7.4 Device Functional Modes

#### 7.4.1 Input and Output Stage

The rail-to-rail input stage of this family provides more flexibility for the designer. The LMV93x-N use a complimentary PNP and NPN input stage in which the PNP stage senses common-mode voltage near V<sup>-</sup> and the NPN stage senses common-mode voltage near V<sup>+</sup>. The transition from the PNP stage to NPN stage occurs 1 V below V<sup>+</sup>. Because both input stages have their own offset voltage, the offset of the amplifier becomes a function of the input common-mode voltage and has a crossover point at 1 V below V<sup>+</sup>.



### **Device Functional Modes (continued)**

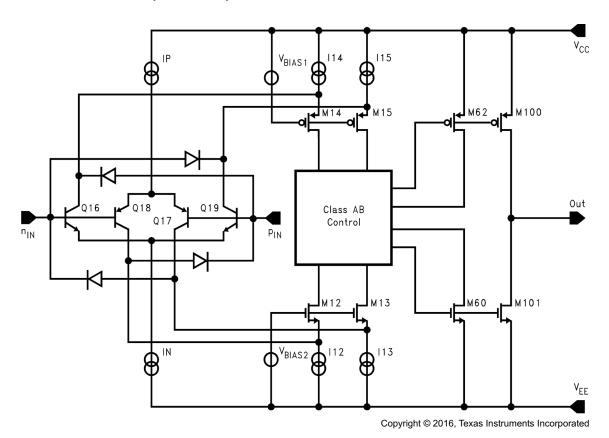


Figure 29. Simplified Schematic Diagram

This  $V_{OS}$  crossover point can create problems for both DC- and AC-coupled signals if proper care is not taken. Large input signals that include the  $V_{OS}$  crossover point will cause distortion in the output signal. One way to avoid such distortion is to keep the signal away from the crossover. For example, in a unity gain buffer configuration with  $V_S = 5$  V, a 5-V peak-to-peak signal will contain input-crossover distortion while a 3-V peak-to-peak signal centered at 1.5 V will not contain input-crossover distortion as it avoids the crossover point. Another way to avoid large signal distortion is to use a gain of -1 circuit which avoids any voltage excursions at the input terminals of the amplifier. In that circuit, the common-mode DC voltage can be set at a level away from the  $V_{OS}$  cross-over point. For small signals, this transition in  $V_{OS}$  shows up as a  $V_{CM}$  dependent spurious signal in series with the input signal and can effectively degrade small signal parameters such as gain and common-mode rejection ratio. To resolve this problem, the small signal should be placed such that it avoids the  $V_{OS}$  crossover point. In addition to the rail-to-rail performance, the output stage can provide enough output current to drive 600-  $\Omega$  loads. Because of the high-current capability, take care not to exceed the 150°C maximum junction temperature specification.

## 7.4.2 Input Bias Current Consideration

The LMV93x-N family has a complementary bipolar input stage. The typical input bias current ( $I_B$ ) is 15 nA. The input bias current can develop a significant offset voltage. This offset is primarily due to  $I_B$  flowing through the negative feedback resistor,  $R_F$ . For example, if  $I_B$  is 50 nA and  $R_F$  is 100 k $\Omega$ , then an offset voltage of 5 mV will develop ( $V_{OS} = I_B \times R_F$ ). Using a compensation resistor ( $R_C$ ), as shown in Figure 30, cancels this effect. But the input offset current ( $I_{OS}$ ) will still contribute to an offset voltage in the same manner.

# **Device Functional Modes (continued)**

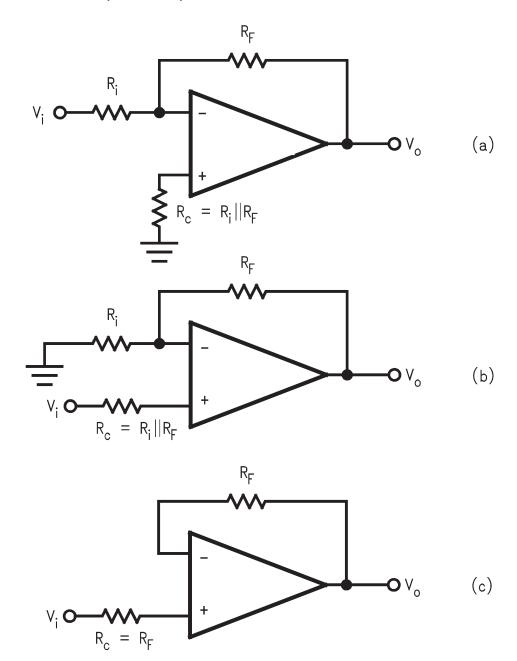


Figure 30. Canceling the Offset Voltage due to Input Bias Current



# 8 Application and Implementation

#### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

## 8.1 Application Information

The LMV93x-N devices bring performance, economy and ease-of-use to low-voltage, low-power systems. They provide rail-to-rail input and rail-to-rail output swings into heavy loads.

## 8.2 Typical Applications

#### 8.2.1 High-Side Current-Sensing Application

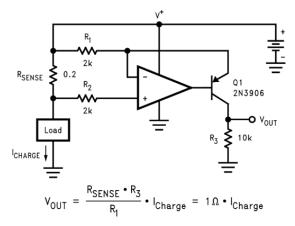


Figure 31. High-Side Current Sensing

#### 8.2.1.1 Design Requirements

The high-side current-sensing circuit (Figure 31) is commonly used in a battery charger to monitor charging current to prevent overcharging. A sense resistor R<sub>SENSE</sub> is connected to the battery directly. This system requires an op amp with rail-to-rail input. The LMV93x-N are ideal for this application because its common-mode input range extends up to the positive supply.

#### 8.2.1.1.1 Custom Design With WEBENCH® Tools

Click here to create a custom design using the LMV93x-N device with the WEBENCH® Power Designer.

- 1. Start by entering the input voltage (V<sub>IN</sub>), output voltage (V<sub>OUT</sub>), and output current (I<sub>OUT</sub>) requirements.
- 2. Optimize the design for key parameters such as efficiency, footprint, and cost using the optimizer dial.
- 3. Compare the generated design with other possible solutions from Texas Instruments.

The WEBENCH Power Designer provides a customized schematic along with a list of materials with real-time pricing and component availability.

In most cases, these actions are available:

- Run electrical simulations to see important waveforms and circuit performance
- Run thermal simulations to understand board thermal performance
- · Export customized schematic and layout into popular CAD formats
- Print PDF reports for the design, and share the design with colleagues

Get more information about WEBENCH tools at www.ti.com/WEBENCH.



#### 8.2.1.2 Detailed Design Procedure

As seen in Figure 31, the  $I_{CHARGE}$  current flowing through sense resistor  $R_{SENSE}$  develops a voltage drop equal to  $V_{SENSE}$ . The voltage at the negative sense point will now be less than the positive sense point by an amount proportional to the  $V_{SENSE}$  voltage.

The low-bias currents of the LMV93x cause little voltage drop through  $R_2$ , so the negative input of the LMV93x amplifier is at essentially the same potential as the negative sense input.

The LMV93x will detect this voltage error between its inputs and servo the transistor base to conduct more current through Q1, increasing the voltage drop across  $R_1$  until the LMV93x inverting input matches the noninverting input. At this point, the voltage drop across  $R_1$  now matches  $V_{SENSE}$ .

I<sub>G</sub>, a current proportional to I<sub>CHARGE</sub>, will flow according to the following relation:

$$I_{G} = V_{RSENSE} / R_{1} = (R_{SENSE} * I_{CHARGE}) / R_{1}$$

$$(2)$$

I<sub>G</sub> also flows through the gain resistor R<sub>3</sub> developing a voltage drop equal to:

$$V_{3} = I_{G} * R_{3} = (V_{RSENSE} / R_{1}) * R_{3} = ((R_{SENSE} * I_{CHARGE}) / R_{2}) * R_{3}$$
(3)

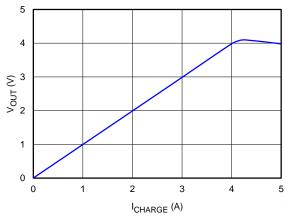


$$V_{OUT} = (R_{SENSE} * I_{CHARGE}) * G$$
 where 
$$\bullet \quad G = R_3 / R_1$$
 (4)

The other channel of the LMV93x may be used to buffer the voltage across R3 to drive the following stages.

## 8.2.1.3 Application Curve

Figure 32 shows the results of the example current sense circuit.



NOTE: the error after 4 V where transistor Q1 runs out of headroom and saturates, limiting the upper output swing.

Figure 32. Current Sense Amplifier Results

## 8.2.2 Half-Wave Rectifier Applications

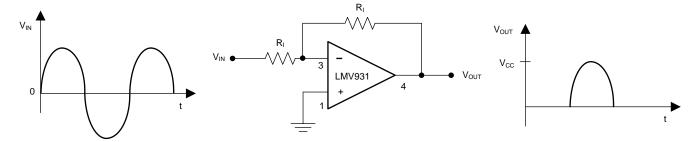


Figure 33. Half-Wave Rectifier With Rail-To-Ground Output Swing Referenced to Ground

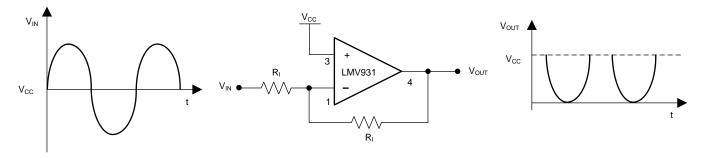


Figure 34. Half-Wave Rectifier With Negative-Going Output Referenced to V<sub>CC</sub>



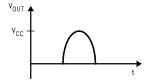
#### 8.2.2.1 Design Requirements

Because the LMV931-N, LMV932-N, LMV934-N input common-mode range includes both positive and negative supply rails and the output can also swing to either supply, achieving half-wave rectifier functions in either direction is an easy task. All that is needed are two external resistors; there is no need for diodes or matched resistors. The half-wave rectifier can have either positive or negative going outputs, depending on the way the circuit is arranged.

## 8.2.2.2 Detailed Design Procedure

In Figure 33 the circuit is referenced to ground, while in Figure 34 the circuit is biased to the positive supply. These configurations implement the half-wave rectifier because the LMV93x-N can not respond to one-half of the incoming waveform. It can not respond to one-half of the incoming because the amplifier cannot swing the output beyond either rail therefore the output disengages during this half cycle. During the other half cycle, however, the amplifier achieves a half wave that can have a peak equal to the total supply voltage. R<sub>I</sub> should be large enough not to load the LMV93x-N.

#### 8.2.2.3 Application Curve



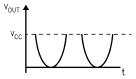


Figure 35. Output of Ground-to-Rail Circuit

Figure 36. Output of Rail-to-Ground Circuit

## 8.2.3 Instrumentation Amplifier With Rail-to-Rail Input and Output Application

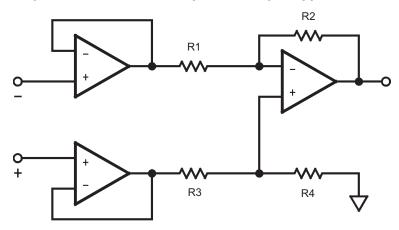


Figure 37. Rail-to-Rail Instrumentation Amplifier

#### 8.2.3.1 Design Requirements

Using three of the LMV93x-N amplifiers, an instrumentation amplifier with rail-to-rail inputs and outputs can be made as shown in Figure 37.

#### 8.2.3.2 Detailed Design Procedure

In this example, amplifiers on the left side act as buffers to the differential stage. These buffers assure that the input impedance is very high. They also assure that the difference amp is driven from a voltage source. This is necessary to maintain the CMRR set by the matching  $R_1$ - $R_2$  with  $R_3$ - $R_4$ . The gain is set by the ratio of  $R_2/R_1$  and  $R_3$  should equal  $R_1$  and  $R_4$  equal  $R_2$ . With both rail-to-rail input and output ranges, the input and output are only limited by the supply voltages. Remember that even with rail-to-rail outputs, the output can not swing past the supplies so the combined common-mode voltages plus the signal should not be greater that the supplies or limiting will occur.



#### 8.2.3.3 Application Curve

Figure 38 shows the results of the instrumentation amplifier with  $R_1$  and  $R_3$  = 1 K, and  $R_2$  and  $R_4$  = 100 k $\Omega$ , for a gain of 100, running on a single 5-V supply with a input of  $V_{CM} = V_S/2$ . The combined effects of the individual offset voltages can be seen as a shift in the offset of the curve.

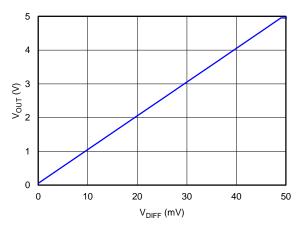


Figure 38. Instrumentation Amplifier Output Results

#### 8.3 Dos and Don'ts

Do properly bypass the power supplies.

Do add series resistence to the output when driving capacitive loads, particularly cables, Muxes and ADC inputs.

Do add series current limiting resistors and external schottky clamp diodes if input voltage is expected to exceed the supplies. Limit the current to 1 mA or less (1  $k\Omega$  per volt).

# 9 Power Supply Recommendations

For proper operation, the power supplies must be properly decoupled. For decoupling the supply lines, TI recommends that 10-nF capacitors be placed as close as possible to the op amp power supply pins. For single-supply, place a capacitor between  $V^+$  and  $V^-$  supply leads. For dual supplies, place one capacitor between  $V^+$  and ground, and one capacitor between  $V^-$  and ground.



# 10 Layout

## 10.1 Layout Guidelines

The V<sup>+</sup> pin must be bypassed to ground with a low-ESR capacitor.

The optimum placement is closest to the V<sup>+</sup> and ground pins.

Take care to minimize the loop area formed by the bypass capacitor connection between V<sup>+</sup> and ground.

The ground pin must be connected to the PCB ground plane at the pin of the device.

The feedback components should be placed as close as possible to the device minimizing strays.

## 10.2 Layout Example

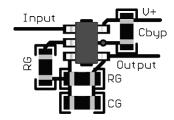


Figure 39. SOT-23 Layout Example



# 11 Device and Documentation Support

## 11.1 Device Support

#### 11.1.1 Custom Design With WEBENCH® Tools

Click here to create a custom design using the LMV93x-N device with the WEBENCH® Power Designer.

- 1. Start by entering the input voltage (V<sub>IN</sub>), output voltage (V<sub>OUT</sub>), and output current (I<sub>OUT</sub>) requirements.
- 2. Optimize the design for key parameters such as efficiency, footprint, and cost using the optimizer dial.
- 3. Compare the generated design with other possible solutions from Texas Instruments.

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In most cases, these actions are available:

- Run electrical simulations to see important waveforms and circuit performance
- Run thermal simulations to understand board thermal performance
- · Export customized schematic and layout into popular CAD formats
- Print PDF reports for the design, and share the design with colleagues

Get more information about WEBENCH tools at www.ti.com/WEBENCH.

#### 11.1.2 Development Support

LMV931 PSPICE Model (also applicable to the LMV932 and LMV934), http://www.ti.com/lit/zip/snom028

TINA-TI SPICE-Based Analog Simulation Program, http://www.ti.com/tool/tina-ti

DIP Adapter Evaluation Module, http://www.ti.com/tool/dip-adapter-evm

TI Universal Operational Amplifier Evaluation Module, http://www.ti.com/tool/opampevm

TI Filterpro Software, http://www.ti.com/tool/filterpro

#### 11.2 Documentation Support

#### 11.2.1 Related Documentation

For additional applications, see

AN-31 Op Amp Circuit Collection

#### 11.3 Related Links

Table 1 lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to order now.

Table 1. Related Links

PARTS	PRODUCT FOLDER	ORDER NOW	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
LMV931-N	Click here	Click here	Click here	Click here	Click here
LMV932-N	Click here	Click here	Click here	Click here	Click here
LMV934-N	Click here	Click here	Click here	Click here	Click here

#### 11.4 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.



### 11.5 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support TI's Design Support Quickly find helpful E2E forums along with design support tools and contact information for technical support.

#### 11.6 Trademarks

E2E is a trademark of Texas Instruments. WEBENCH is a registered trademark of Texas Instruments. All other trademarks are the property of their respective owners.

### 11.7 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

# 11.8 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

# 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.





3-Nov-2018

## **PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
LMV931MF	NRND	SOT-23	DBV	5	1000	TBD	Call TI	Call TI	-40 to 125	A79A	
LMV931MF/NOPB	ACTIVE	SOT-23	DBV	5	1000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	A79A	Samples
LMV931MFX	NRND	SOT-23	DBV	5	3000	TBD	Call TI	Call TI	-40 to 125	A79A	
LMV931MFX/NOPB	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	A79A	Samples
LMV931MG	NRND	SC70	DCK	5	1000	TBD	Call TI	Call TI	-40 to 125	A74	
LMV931MG/NOPB	ACTIVE	SC70	DCK	5	1000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	A74	Samples
LMV931MGX/NOPB	ACTIVE	SC70	DCK	5	3000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	A74	Samples
LMV932MA/NOPB	ACTIVE	SOIC	D	8	95	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	LMV9 32MA	Samples
LMV932MAX	NRND	SOIC	D	8	2500	TBD	Call TI	Call TI	-40 to 125	LMV9 32MA	
LMV932MAX/NOPB	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	LMV9 32MA	Samples
LMV932MM	NRND	VSSOP	DGK	8	1000	TBD	Call TI	Call TI	-40 to 125	A86A	
LMV932MM/NOPB	ACTIVE	VSSOP	DGK	8	1000	Green (RoHS & no Sb/Br)	CU NIPDAUAG   CU SN	Level-1-260C-UNLIM	-40 to 125	A86A	Samples
LMV932MMX/NOPB	ACTIVE	VSSOP	DGK	8	3500	Green (RoHS & no Sb/Br)	CU NIPDAUAG   CU SN	Level-1-260C-UNLIM	-40 to 125	A86A	Samples
LMV934MA	NRND	SOIC	D	14	55	TBD	Call TI	Call TI	-40 to 125	LMV934MA	
LMV934MA/NOPB	ACTIVE	SOIC	D	14	55	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	LMV934MA	Samples
LMV934MAX/NOPB	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 125	LMV934MA	Samples
LMV934MT/NOPB	ACTIVE	TSSOP	PW	14	94	Green (RoHS & no Sb/Br)	CU NIPDAU   CU SN	Level-1-260C-UNLIM	-40 to 125	LMV93 4MT	Samples
LMV934MTX	NRND	TSSOP	PW	14	2500	TBD	Call TI	Call TI	-40 to 125	LMV93 4MT	
LMV934MTX/NOPB	ACTIVE	TSSOP	PW	14	2500	Green (RoHS & no Sb/Br)	CU NIPDAU   CU SN	Level-1-260C-UNLIM	-40 to 125	LMV93 4MT	Samples





3-Nov-2018

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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#### OTHER QUALIFIED VERSIONS OF LMV931-N, LMV932-N, LMV934-N:

Automotive: LMV931-N-Q1, LMV932-N-Q1, LMV934-N-Q1

NOTE: Qualified Version Definitions:

Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

# PACKAGE MATERIALS INFORMATION

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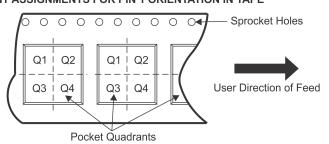
## TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
LMV931MF	SOT-23	DBV	5	1000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LMV931MF/NOPB	SOT-23	DBV	5	1000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LMV931MFX	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LMV931MFX/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LMV931MG	SC70	DCK	5	1000	178.0	8.4	2.25	2.45	1.2	4.0	8.0	Q3
LMV931MG/NOPB	SC70	DCK	5	1000	178.0	8.4	2.25	2.45	1.2	4.0	8.0	Q3
LMV931MGX/NOPB	SC70	DCK	5	3000	178.0	8.4	2.25	2.45	1.2	4.0	8.0	Q3
LMV932MAX	SOIC	D	8	2500	330.0	12.4	6.5	5.4	2.0	8.0	12.0	Q1
LMV932MAX/NOPB	SOIC	D	8	2500	330.0	12.4	6.5	5.4	2.0	8.0	12.0	Q1
LMV932MM	VSSOP	DGK	8	1000	178.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
LMV932MM/NOPB	VSSOP	DGK	8	1000	178.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
LMV932MMX/NOPB	VSSOP	DGK	8	3500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
LMV934MAX/NOPB	SOIC	D	14	2500	330.0	16.4	6.5	9.35	2.3	8.0	16.0	Q1
LMV934MTX	TSSOP	PW	14	2500	330.0	12.4	6.95	5.6	1.6	8.0	12.0	Q1
LMV934MTX/NOPB	TSSOP	PW	14	2500	330.0	12.4	6.95	5.6	1.6	8.0	12.0	Q1
LMV934MTX/NOPB	TSSOP	PW	14	2500	330.0	12.4	6.95	5.6	1.6	8.0	12.0	Q1

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\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
LMV931MF	SOT-23	DBV	5	1000	210.0	185.0	35.0
LMV931MF/NOPB	SOT-23	DBV	5	1000	210.0	185.0	35.0
LMV931MFX	SOT-23	DBV	5	3000	210.0	185.0	35.0
LMV931MFX/NOPB	SOT-23	DBV	5	3000	210.0	185.0	35.0
LMV931MG	SC70	DCK	5	1000	210.0	185.0	35.0
LMV931MG/NOPB	SC70	DCK	5	1000	210.0	185.0	35.0
LMV931MGX/NOPB	SC70	DCK	5	3000	210.0	185.0	35.0
LMV932MAX	SOIC	D	8	2500	367.0	367.0	35.0
LMV932MAX/NOPB	SOIC	D	8	2500	367.0	367.0	35.0
LMV932MM	VSSOP	DGK	8	1000	210.0	185.0	35.0
LMV932MM/NOPB	VSSOP	DGK	8	1000	210.0	185.0	35.0
LMV932MMX/NOPB	VSSOP	DGK	8	3500	367.0	367.0	35.0
LMV934MAX/NOPB	SOIC	D	14	2500	367.0	367.0	35.0
LMV934MTX	TSSOP	PW	14	2500	367.0	367.0	35.0
LMV934MTX/NOPB	TSSOP	PW	14	2500	367.0	367.0	35.0
LMV934MTX/NOPB	TSSOP	PW	14	2500	367.0	367.0	35.0



SMALL OUTLINE TRANSISTOR



- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
  2. This drawing is subject to change without notice.
  3. Reference JEDEC MO-178.

- 4. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.



SMALL OUTLINE TRANSISTOR



NOTES: (continued)

5. Publication IPC-7351 may have alternate designs.

6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE TRANSISTOR



NOTES: (continued)



<sup>7.</sup> Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

<sup>8.</sup> Board assembly site may have different recommendations for stencil design.

# D (R-PDSO-G14)

# PLASTIC SMALL OUTLINE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AB.



# D (R-PDSO-G14)

# PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



PW (R-PDSO-G14)

# PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
  - Sody length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153



# PW (R-PDSO-G14)

# PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.





SMALL OUTLINE INTEGRATED CIRCUIT



- 1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
- 4. This dimension does not include interlead flash.
- 5. Reference JEDEC registration MS-012, variation AA.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE INTEGRATED CIRCUIT



#### NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



# DGK (S-PDSO-G8)

# PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 per end.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.50 per side.
- E. Falls within JEDEC MO-187 variation AA, except interlead flash.



# DGK (S-PDSO-G8)

# PLASTIC SMALL OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



# DCK (R-PDSO-G5)

# PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
- D. Falls within JEDEC MO-203 variation AA.



# DCK (R-PDSO-G5)

# PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
- D. Publication IPC-7351 is recommended for alternate designs.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.



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